



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/661,204	LAIL ET AL.	
	Examiner	Art Unit	
	Hae M. Hyeon	2839	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
385		100		385	102				
INTERNATIONAL CLASSIFICATION									
G	0	2	B	6/44					
				/					
				/					
				/					
				/					

(Assistant Examiner) (Date)		 HAE MOON HYEON PRIMARY EXAMINER 5-16-07 (Primary Examiner) (Date)	Total Claims Allowed: 68	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 1 & 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1		33	31		21	61			121			151			181
2	2		34	32		44	62			122			152			182
3	3		35	33		22	63			123			153			183
4	4		36	34		23	64			124			154			184
5	5		38	35		45	65			125			155			185
6	6		39	36		46	66			126			156			186
7	7		37	37		67	67			127			157			187
8	8		40	38		68	68			128			158			188
9	9		41	39		47	69			129			159			189
10	10		42	40			70			130			160			190
11	11		43	41			71			131			161			191
12	12		48	42			72			132			162			192
13	13		49	43			73			133			163			193
14	14		50	44			74			134			164			194
15	15		51	45			75			135			165			195
16	16		52	46			76			136			166			196
17	17		53	47			77			137			167			197
18	18		54	48			78			138			168			198
19	19		55	49			79			139			169			199
20	20		56	50			80			140			170			200
24	21		57	51			81			141			171			201
	22		58	52			82			142			172			202
25	23		59	53			83			143			173			203
26	24		60	54			84			144			174			204
27	25		61	55			85			145			175			205
28	26		62	56			86			146			176			206
29	27		63	57			87			147			177			207
30	28		64	58			88			148			178			208
31	29		65	59			89			149			179			209
32	30		66	60			90			150			180			210